Controlled Growth of High-Quality CVD Graphene

Luzhao Sun

Beijing Graphene Institute (BGI), Zhigu Center, 13 Cuihu Nanhuan Road, Sujiatuo Town, Haidian District, Beijing, 100095, China. sunlz-cnc@pku.edu.cn

Graphene has garnered widespread interest and confer remarkable potential for next-generation technological applications, which relies on the controllable and mass-production of high-quality graphene films. Chemical vapor deposition (CVD) is considered the most promising method, and great progress has been achieved over the last decade ^[1]. Currently, this field is being pushed to new heights that pursuit structure control (e.g. orientation, laver, stacking order, contamination, doping, etc.) and low-cost production (e.g. increasing the production capacity and growth rate) [2]. In this talk, I will introduce our recent works on controlled growth of high-quality graphene films via CVD approach. By designing and preparing single-crystal Cu foils, we have opportunities in realizing the epitaxial growth of large-area single-crystal graphene film ^[3]. We designed and constructed a pilot-scale CVD system suitable for producing A3-size graphene films, which works well and output high-guality graphene films with high capacity. In another hand, we also explore the possibility on controlling the layer number and stacking order, which is motivated by the emerging twistronics. Here I will present our state-of-the-art hetero-site nucleation method for growing twisted bilayer graphene (tBLG)^[4]. Gasflow perturbation and switching of the graphene edge termination play crucial roles in triggering the formation of interlayer twist. The growth mechanism is carefully investigated by using an isotopelabelling technique. The as-obtained tBLGs show high crystalline guality, which is confirmed by the Raman spectra, atomically clear Moiré patterns in TEM image and ultrahigh carrier mobility (over 50,000 cm² V⁻¹ s⁻¹ at room temperature).

REFERENCES

- [1] L. Sun, G. Yuan, L. Gao, J. Yang, M. Chhowalla, M. H. Gharahcheshmeh, K. K. Gleason, Y. S. Choi, B. H. Hong, Z. Liu, *Nat. Rev. Methods Primers* **2021**, 1, 5.
- [2] J. Zhang, L. Sun, K. Jia, X. Liu, T. Cheng, H. Peng, L. Lin, Z. Liu, ACS Nano **2020**, 14, 10796.
- [3] Y. Li, L. Sun, H. Liu, Y. Wang, Z. Liu, Inorg. Chem. Front. 2020, 8(1): 182-200.
- [4] L. Sun, Z. Wang, Y. Wang, L. Zhao, Y. Li, B. Chen, S. Huang, S. Zhang, W. Wang, D. Pei, H. Fang, S. Zhong, H. Liu, J. Zhang, L. Tong, Y. Chen, Z. Li, M. H. Rümmeli, K. S. Novoselov, H. Peng, L. Lin, Z. Liu, *Nat. Commun.* 2021, Accepted.

FIGURES



